

| | | | | |
|-----------------------------------|--|-------------------------|--|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination MACKIEWICH ET AL. | |
| | | Examiner | Art Unit | Page 1 of 1 |
| U.S. PATENT DOCUMENTS | | | | |

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-2002/0083344 | 06-2002 | Vairavan, Kannan P. | 713/201 |
| * | B | US-2006/0262798 | 11-2006 | Joshi et al. | 370/392 |
| * | C | US-7,170,897 | 01-2007 | Mackiewich et al. | 370/401 |
| * | D | US-2003/0198182 | 10-2003 | Pegrum et al. | 370/225 |
| * | E | US-6,181,702 | 01-2001 | Egbert, Chandan | 370/401 |
| * | F | US-6,128,296 | 10-2000 | Daruwalla et al. | 370/389 |
| * | G | US-6,765,914 | 07-2004 | Jain et al. | 370/395.31 |
| * | H | US-2002/0089983 | 07-2002 | Lin et al. | 370/392 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.